


Search Notes 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/642,790		MURAKAMI, TAKEHIKO	
	Examiner		Art Unit	
	Randall Chin		1744	

SEARCHED			
Class	Subclass	Date	Examiner
15	1		
15	3		
101	423		
101	424	8/20/2005	RC
UPDATED SEARCH		11/09/05	RC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
SAME AS ABOVE		11/09/05	RC

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, OCR, DERWENT, EPO, JPO	8/20/2005	RC
Inventor name search	8/20/2005	RC

11/09/2005